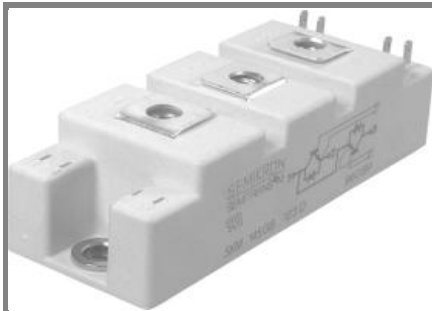


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SEMITRANS™ 2

IGBT Modules

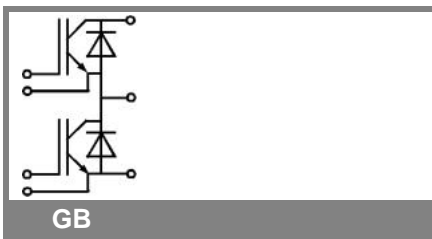
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Features

- N channel, Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to $6 \times I_{Cnom}$
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (10 mm) and creepage distance (20 mm)

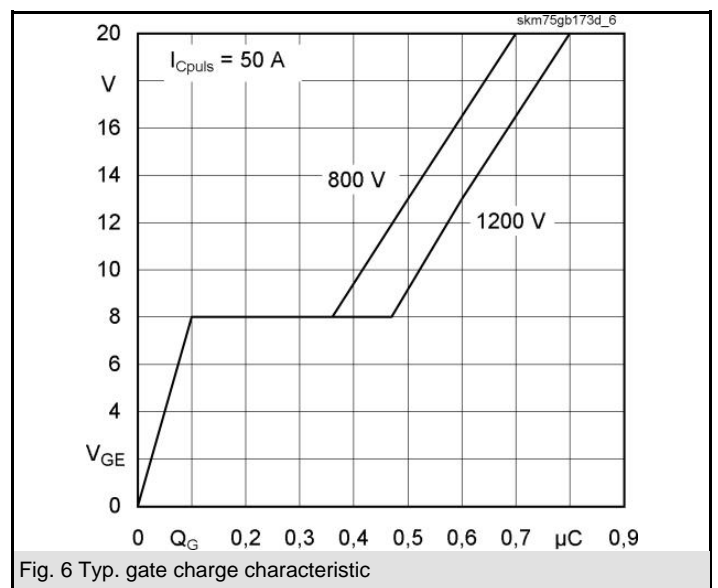
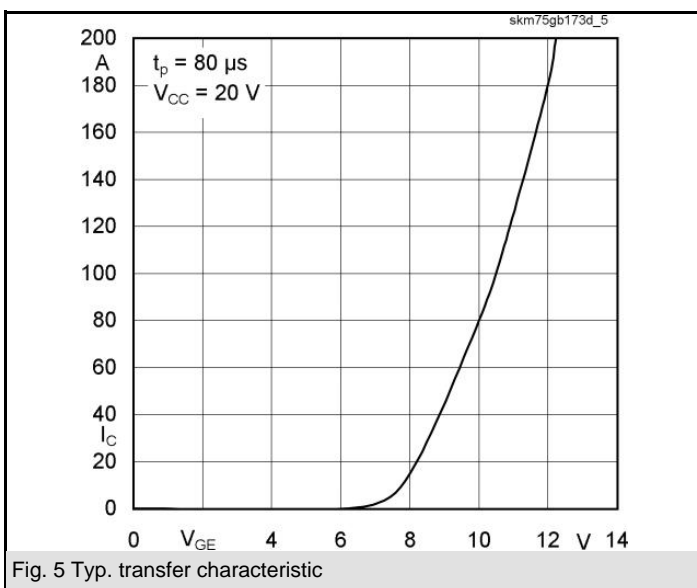
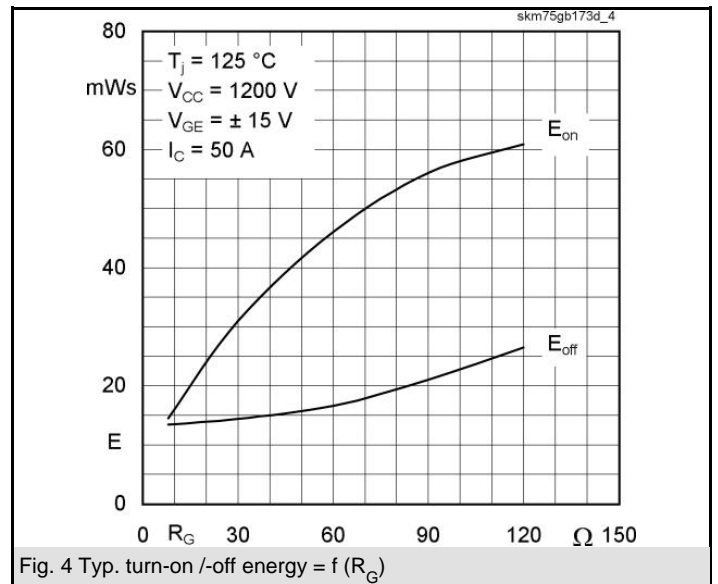
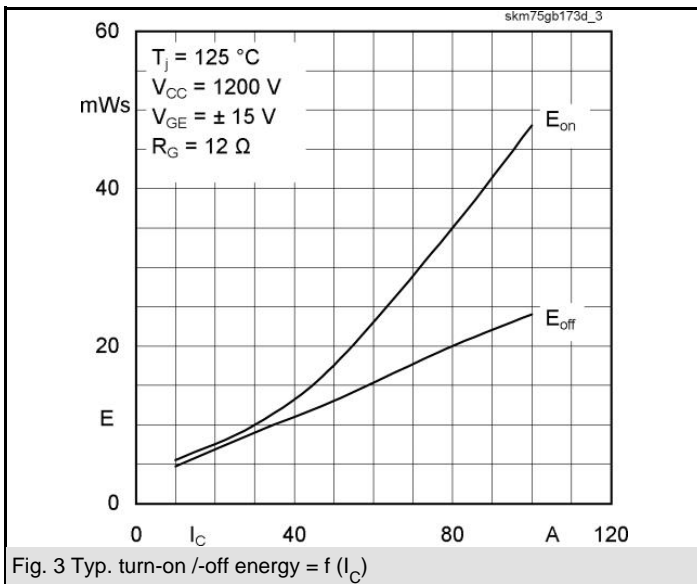
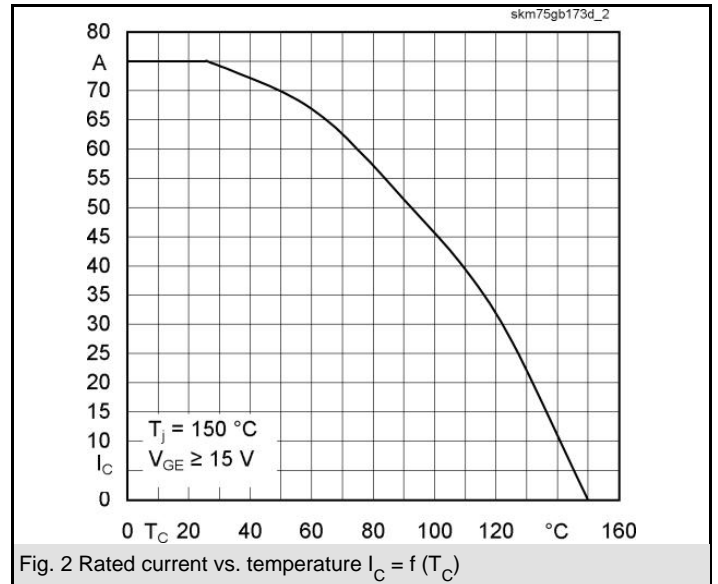
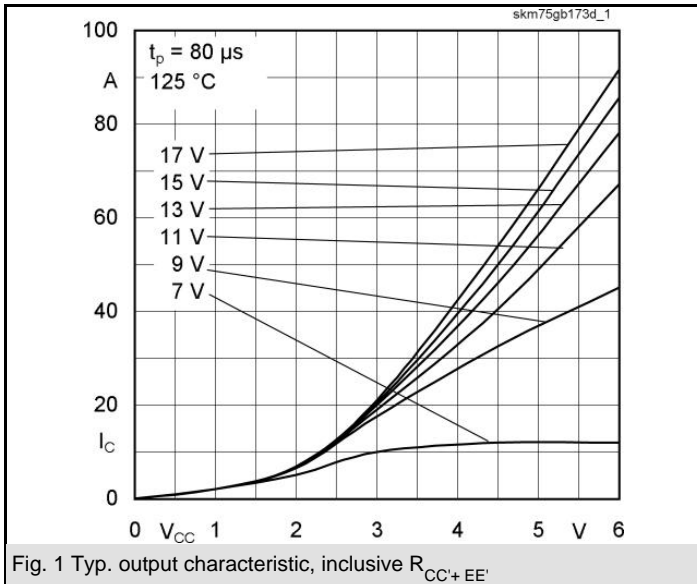
Typical Applications

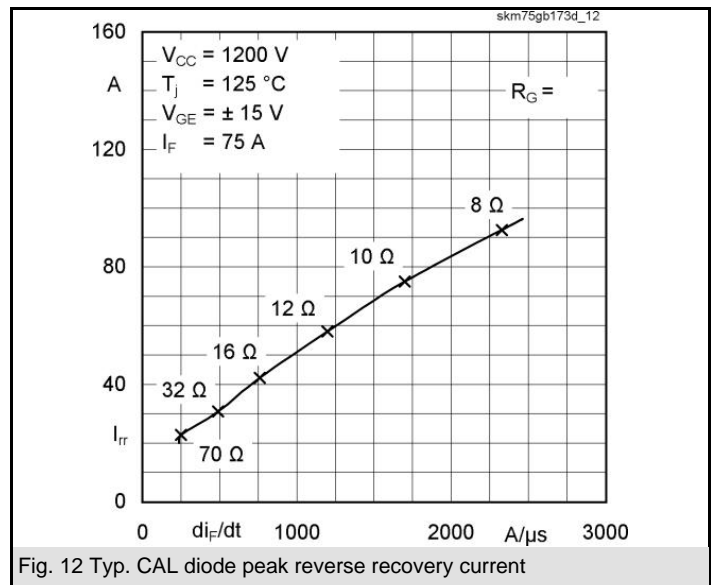
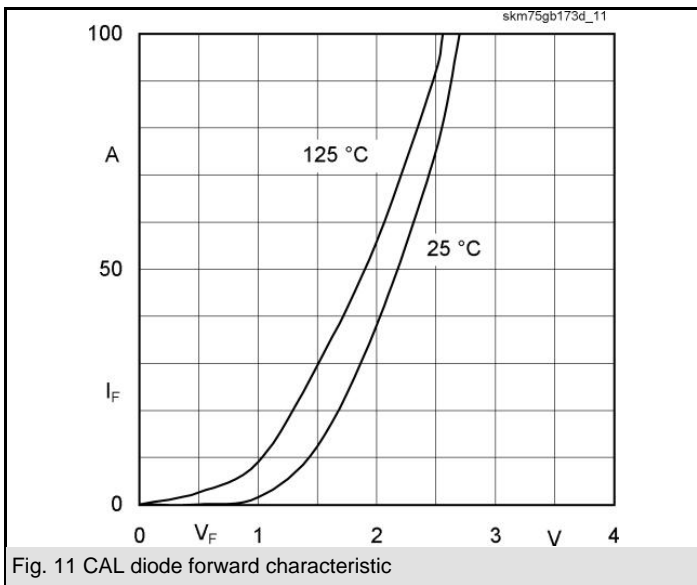
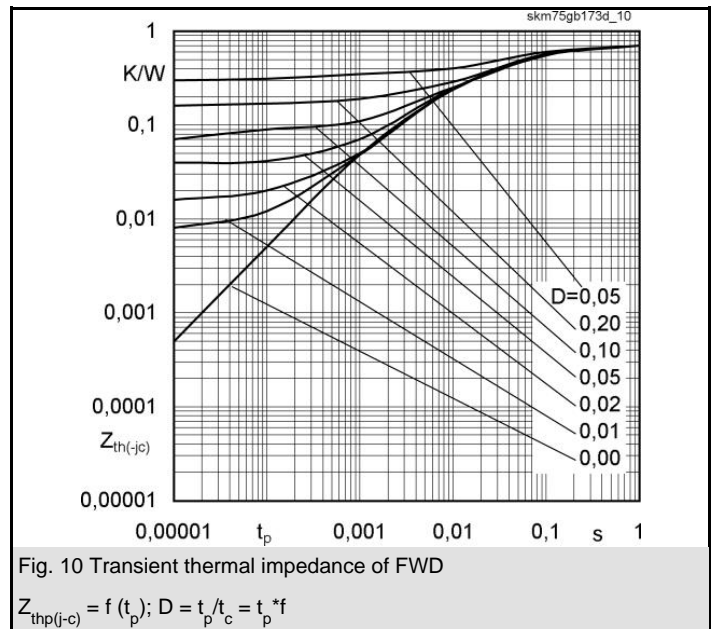
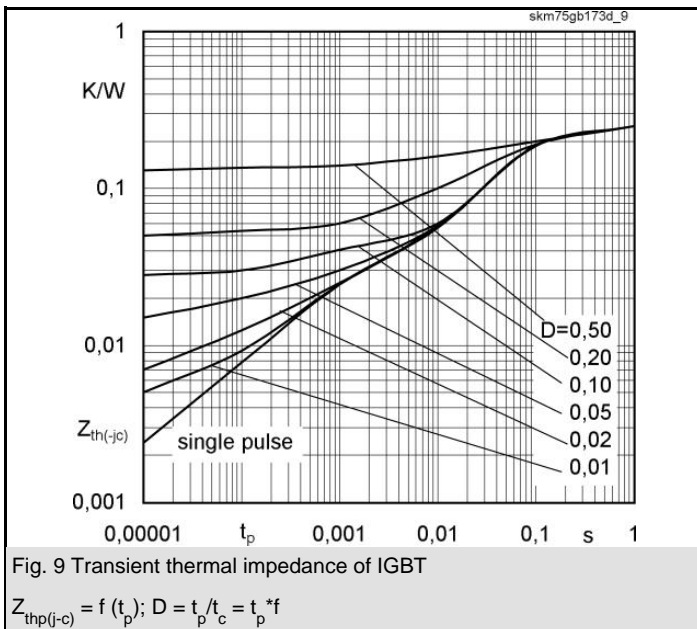
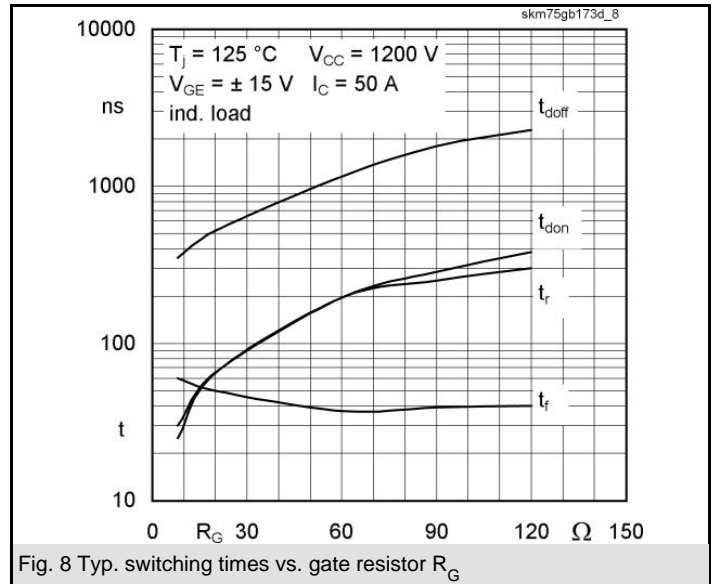
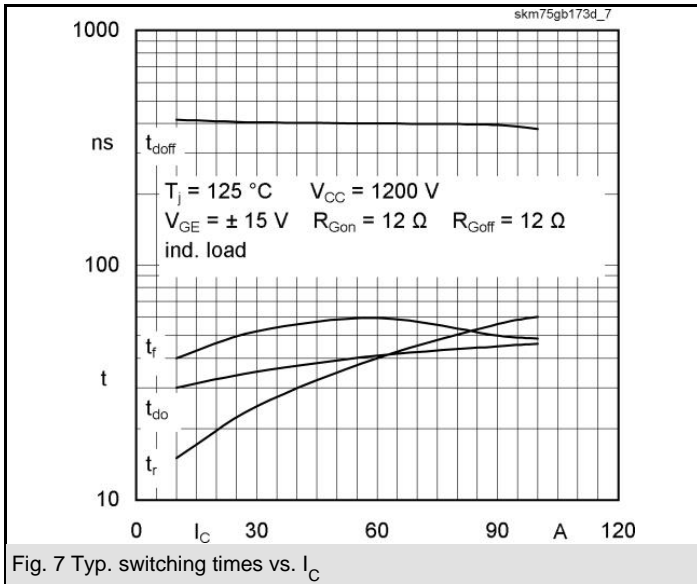
- AC inverter drives on mains 575 - 750 V_{AC}
- DC bus voltage 750 - 1200 V_{DC}
- Public transport (auxiliary syst.)
- Switching (not for linear use)



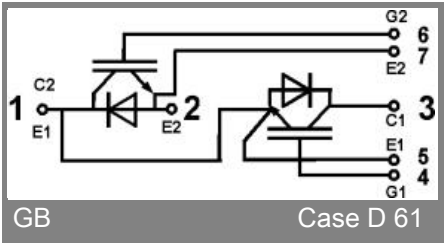
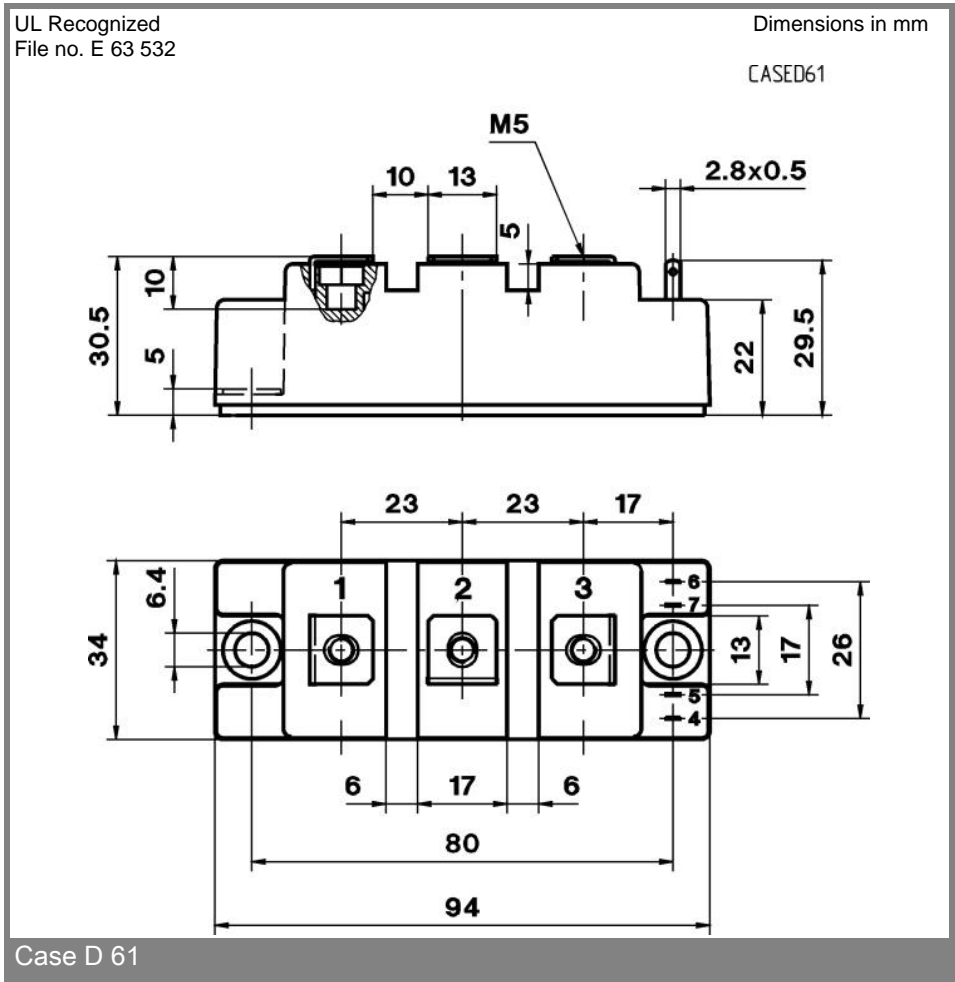
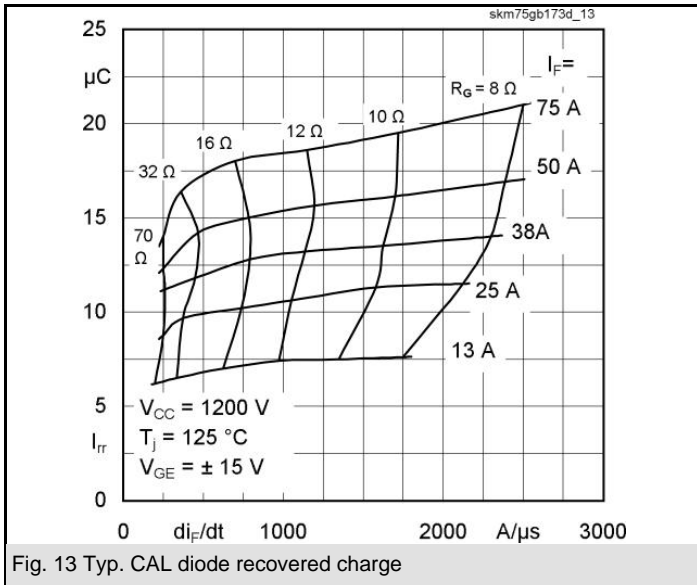
| Absolute Maximum Ratings | | $T_c = 25\text{ }^\circ\text{C}$, unless otherwise specified | |
|--------------------------|--|---|------------------|
| Symbol | Conditions | Values | Units |
| IGBT | | | |
| V_{CES} | | 1700 | V |
| I_C | $T_c = 25\text{ (80) }^\circ\text{C}$ | 75 (50) | A |
| I_{CRM} | $t_p = 1\text{ ms}$ | 100 | A |
| V_{GES} | | ± 20 | V |
| T_{vj} (T_{stg}) | $T_{OPERATION} \leq T_{stg}$ | - 40 ... + 150 (1 25) | $^\circ\text{C}$ |
| V_{isol} | AC, 1 min. | 4000 | V |
| Inverse diode | | | |
| I_F | $T_c = 25\text{ (80) }^\circ\text{C}$ | 60 (40) | A |
| I_{FRM} | $t_p = 1\text{ ms}$ | 100 | A |
| I_{FSM} | $t_p = 10\text{ ms}$; sin.; $T_j = 150\text{ }^\circ\text{C}$ | 550 | A |

| Characteristics | | $T_c = 25\text{ }^\circ\text{C}$, unless otherwise specified | | | |
|--------------------------------|---|---|------------|------------|---------------|
| Symbol | Conditions | min. | typ. | max. | Units |
| IGBT | | | | | |
| $V_{GE(th)}$ | $V_{GE} = V_{CE}$; $I_C = 4\text{ mA}$ | 4,8 | 5,5 | 6,2 | V |
| I_{CES} | $V_{GE} = 0$; $V_{CE} = V_{CES}$; $T_j = 25\text{ (125) }^\circ\text{C}$ | | 0,1 | 0,3 | mA |
| $V_{CE(TO)}$ | $T_j = 25\text{ (125) }^\circ\text{C}$ | | 1,65 (1,9) | 1,9 (2,15) | V |
| r_{CE} | $V_{GE} = 20\text{ V}$; $T_j = 25\text{ (125) }^\circ\text{C}$ | | 35 (46) | 40 (57) | m Ω |
| $V_{CE(sat)}$ | $I_{Cnom} = 50\text{ A}$; $V_{GE} = 15\text{ V}$; chip level | | 3,4 (4,2) | 3,9 (5) | V |
| C_{ies} | under following conditions | | 8 | | nF |
| C_{oes} | $V_{GE} = 0$; $V_{CE} = 25\text{ V}$; $f = 1\text{ MHz}$ | | 0,64 | | nF |
| C_{res} | | | 0,25 | | nF |
| L_{CE} | | | | 30 | nH |
| $R_{CC'+EE'}$ | res.; terminal-chip $T_c = 25\text{ (125) }^\circ\text{C}$ | | 0,75 (1) | | m Ω |
| $t_{d(on)}$ | $V_{CC} = 1200\text{ V}$; $I_{Cnom} = 50\text{ A}$ | | 40 | | ns |
| t_r | $R_{Gon} = R_{Goff} = 12\text{ }^\circ\Omega$; $T_j = 125\text{ }^\circ\text{C}$ | | 35 | | ns |
| $t_{d(off)}$ | $V_{GE} = \pm 15\text{ V}$ | | 400 | 600 | ns |
| t_f | | | 58 | | ns |
| $E_{on} (E_{off})$ | | | 18 (13) | | mJ |
| Inverse diode | | | | | |
| $V_F = V_{EC}$ | $I_{Fnom} = 50\text{ A}$; $V_{GE} = 0\text{ V}$; $T_j = 25\text{ (125) }^\circ\text{C}$ | | 2,2 (2) | 2,7 (2,4) | V |
| $V_{(TO)}$ | $T_j = 125\text{ () }^\circ\text{C}$ | | 1,3 | 1,5 | V |
| r_T | $T_j = 125\text{ () }^\circ\text{C}$ | | 12 | 18 | m Ω |
| I_{RRM} | $I_{Fnom} = 50\text{ A}$; $T_j = 25\text{ (125) }^\circ\text{C}$ | | 30 (43) | | A |
| Q_{rr} | $di/dt = 800\text{ A}/\mu\text{s}$ | | 7 (15) | | μC |
| E_{rr} | $V_{GE} = V$ | | | | mJ |
| Thermal characteristics | | | | | |
| $R_{th(j-c)}$ | per IGBT | | | 0,25 | K/W |
| $R_{th(j-c)D}$ | per Inverse Diode | | | 0,75 | K/W |
| $R_{th(c-s)}$ | per module | | | 0,05 | K/W |
| Mechanical data | | | | | |
| M_s | to heatsink M6 | 3 | | 5 | Nm |
| M_t | to terminals M5 | 2,5 | | 5 | Nm |
| w | | | | 160 | g |





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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.